Attorney's Docket No.: 14603-028US1 / P2004,0195 US N

IAP9 Rec'd PCT/PTO 2 9 AUG 2006

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Gerhard Fritz

Art Unit : Unknown

Serial No.: N/A

Examiner: Unknown

Filed

: Herewith

Title

: ENERGY METER SYSTEM AND METHOD FOR CALIBRATION

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicants request consideration of the references listed on the attached PTO-1449 form. Under 37 C.F.R. § 1.98 (a)(2)(ii), only copies of foreign patent documents and/or non-patent literature are enclosed. Copies of any listed U.S. patents or U.S. patent application publications can be provided upon request.

This statement is being filed with the application. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Reg. No. 57,861

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Substitute Form PTO-1449 (Modified)

U.S. Department of Commerce Patent and Trademark Office Attorney's Docket No. 14603-028US1

Application No.

Information Disclosure Statement by Applicant

(Use several sheets if necessary)

Gerhard Fritz

Filing Date

Applicant

Group Art Unit

(37 CFR §1.98(b))

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	6,377,037	04/23/2002	Gordon Burns et al			
	AB	6,373,415	04/16/2002	Eric King et al			
	AC	5,017,860	05/21/1991	Warren Germer et al			
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	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Translation	
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
	AL	692 28 850	10/07/99	Germany			Abstract	
	AM	35 14 371	10/23/86	Germany			Abstract	
	AN	27 08 075	08/24/78	Germany			Abstract	
	AO	26 30 959	01/12/78	Germany			Abstract	
	AP	62-162917	07/18/87	Abstracts of Japan				
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	AS	0 534 583	04/07/99	EPO				
	AT	1 563 677	03/26/80	Great Britain				
	AU	1 575 148	09/17/80	Great Britain			·	

Other Documents (include Author, Title, Date, and Place of Publication)				
Examiner	Desig.			
Initial	ID D	Document		

Examiner	S	ignature

Date Considered

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Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office			
Information Disclosure Statement by Applicant (Use several sheets if necessary)		Applicant Gerhard Fritz		
		Filing Date	Group Art Unit	
(37 CFR §1.98(b))				

Other Documents (include Author, Title, Date, and Place of Publication)				
Examiner	Desig.			
Initial	ID	Document		
	AV	Nagura, H. et al. "Correction Method for a Single Chip Power Meter" IMTC, 1994 May 10-12, pp 1313-1316, XP 01021767, ISBN 0-7803-1880-3		
	AW			
	AX			
	AY			

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